## NXS0104-Q100

# Dual supply translating transceiver; open drain; auto direction sensing

Rev. 5 — 2 May 2022

**Product data sheet** 

### 1. General description

The NXS0104-Q100 is a 4-bit, dual supply translating transceiver with auto direction sensing, that enables bidirectional voltage level translation. It features two 4-bit input-output ports (An and Bn), one output enable input (OE) and two supply pins ( $V_{CC(A)}$  and  $V_{CC(B)}$ ).  $V_{CC(A)}$  can be supplied at any voltage between 1.65 V and 3.6 V and  $V_{CC(B)}$  can be supplied at any voltage between 2.3 V and 5.5 V, making the device suitable for translating between any of the voltage nodes (1.8 V, 2.5 V, 3.3 V and 5.0 V). Pins An and OE are referenced to  $V_{CC(A)}$  and pins Bn are referenced to  $V_{CC(B)}$ . A LOW level at pin OE causes the outputs to assume a high-impedance OFF-state. This device is fully specified for partial power-down applications using  $I_{OFF}$ . The  $I_{OFF}$  circuitry disables the output, preventing the damaging backflow current through the device when it is powered down.

This product has been qualified to the Automotive Electronics Council (AEC) standard Q100 (Grade 1) and is suitable for use in automotive applications.

### 2. Features and benefits

- Automotive product qualification in accordance with AEC-Q100 (Grade 1)
  - Specified from -40 °C to +85 °C and from -40 °C to +125 °C
- Wide supply voltage range:
  - V<sub>CC(A)</sub>: 1.65 V to 3.6 V and V<sub>CC(B)</sub>: 2.3 V to 5.5 V
- Maximum data rates:
  - · Push-pull: 24 Mbps
- I<sub>OFF</sub> circuitry provides partial Power-down mode operation
- Inputs accept voltages up to 5.5 V
- ESD protection:
  - HBM: ANSI/ESDA/Jedec JS-001 Class 2 exceeds 2.5 kV for A port
  - HBM: ANSI/ESDA/Jedec JS-001 Class 3B exceeds 15 kV for B port
  - MIL-STD-883, method 3015 Class 2 exceeds 2.5 kV for A port
  - MIL-STD-883, method 3015 Class 3B exceeds 15 kV for B port
  - IEC61000-4-2 contact discharge exceeds 8000 V for B port
- Latch-up performance exceeds 100 mA per JESD 78B Class II
- · Multiple package options
- DHVQFN package with Side-Wettable Flanks enabling Automatic Optical Inspection (AOI) of solder joints

## 3. Ordering information

### **Table 1. Ordering information**

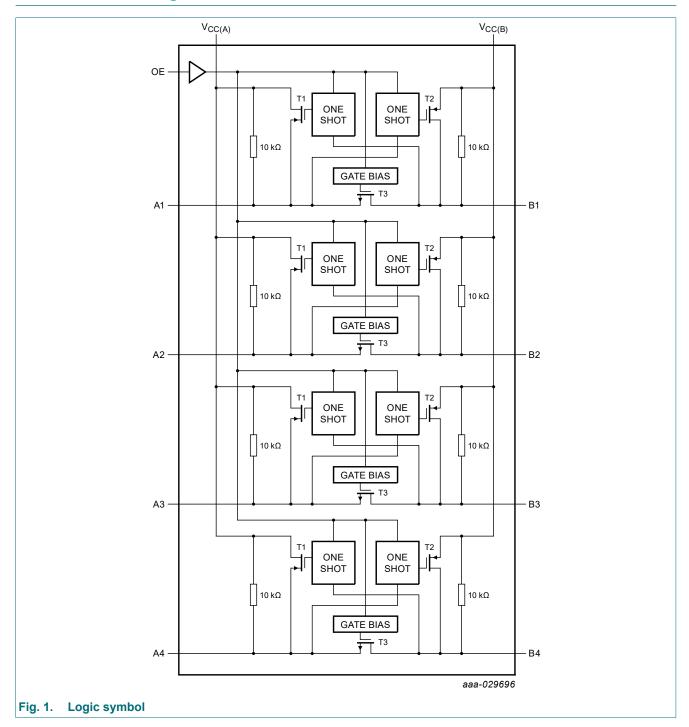
Type number	Package			
	Temperature range	Name	Description	Version
NXS0104PW-Q100	-40 °C to +125 °C	TSSOP14	plastic thin shrink small outline package; 14 leads; body width 4.4 mm	SOT402-1
NXS0104BQ-Q100	-40 °C to +125 °C	DHVQFN14	plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 14 terminals; body 2.5 × 3 × 0.85 mm	SOT762-1
NXS0104GU12-Q100	-40 °C to +125 °C	XQFN12	plastic, extremely thin quad flat package; no leads; 12 terminals; body 1.70 × 2.0 × 0.50 mm	SOT1174-1

## 4. Marking

### Table 2. Marking

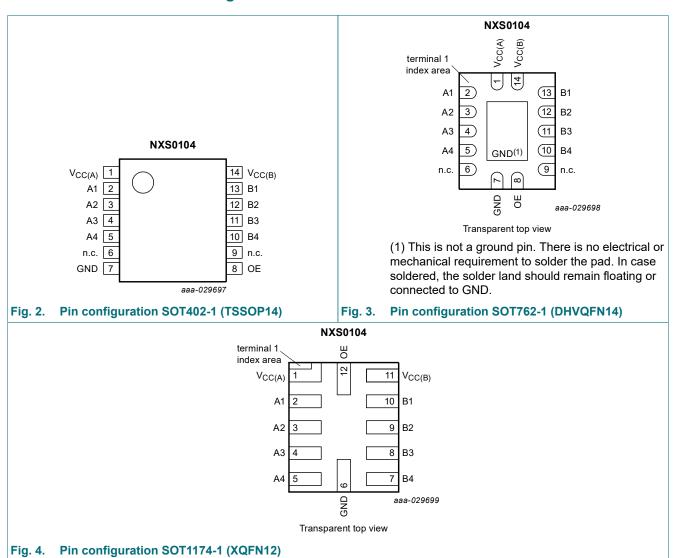
Type number	Marking code
NXS0104PW-Q100	NXS0104
NXS0104BQ-Q100	S0104
NXS0104GU12-Q100	m4

## 5. Functional diagram



### 6. Pinning information

### 6.1. Pinning



### 6.2. Pin description

Table 3. Pin description

Symbol	Pin		Description
	SOT402-1, SOT762-1	SOT1174-1	
V <sub>CC(A)</sub>	1	1	supply voltage A
A1, A2, A3, A4	2, 3, 4, 5	2, 3, 4, 5	data input or output (referenced to V <sub>CC(A)</sub> )
n.c.	6, 9	-	not connected
GND	7	6	ground (0 V)
OE	8	12	output enable input (active HIGH; referenced to V <sub>CC(A)</sub> )
B4, B3, B2, B1	10, 11, 12, 13	7, 8, 9, 10	data input or output (referenced to V <sub>CC(B)</sub> )
V <sub>CC(B)</sub>	14	11	supply voltage B

### 7. Functional description

#### **Table 4. Function table**

H = HIGH voltage level; L = LOW voltage level; X = don't care; Z = high-impedance OFF-state.

Supply voltage		Input	Input/output		
V <sub>CC(A)</sub> [1]	V <sub>CC(B)</sub> OE		An	Bn	
1.65 V to 3.6 V	2.3 V to 5.5 V	L	Z	Z	
1.65 V to 3.6 V	2.3 V to 5.5 V	Н	input or output	output or input	
GND[2]	GND[2]	X	Z	Z	

### 8. Limiting values

### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V <sub>CC(A)</sub>	supply voltage A			-0.5	+6.5	V
V <sub>CC(B)</sub>	supply voltage B			-0.5	+6.5	V
VI	input voltage	A port and OE input	[1]	-0.5	+6.5	V
		B port	[1]	-0.5	+6.5	V
Vo	output voltage	Active mode	[1] [2]			
		A or B port		-0.5	V <sub>CCO</sub> + 0.5	V
		Power-down or 3-state mode	[1]			
		A port		-0.5	+4.6	V
		B port		-0.5	+6.5	V
I <sub>IK</sub>	input clamping current	V <sub>I</sub> < 0 V		-50	-	mA
I <sub>OK</sub>	output clamping current	V <sub>O</sub> < 0 V		-50	-	mA
Io	output current	V <sub>O</sub> = 0 V to V <sub>CCO</sub>	[2]	-	±50	mΑ
I <sub>CC</sub>	supply current	I <sub>CC(A)</sub> or I <sub>CC(B)</sub>		-	100	mA
I <sub>GND</sub>	ground current			-100	-	mA
T <sub>stg</sub>	storage temperature			-65	+150	°C
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> = -40 °C to +125 °C				
		SOT402-1 (TSSOP14) SOT762-1 (DHVQFN14)	[3]	-	500	mW
		SOT1174-1 (XQFN12)		-	250	mW

The minimum input and minimum output voltage ratings may be exceeded if the input and output current ratings are observed.

 $V_{CC(A)}$  must be less than or equal to  $V_{CC(B)}$  and  $V_{CC(A)}$  must not exceed 3.6 V. When either  $V_{CC(A)}$  or  $V_{CC(B)}$  is at GND level, the device goes into power-down mode.

 $<sup>\</sup>ensuremath{V_{\text{CCO}}}$  is the supply voltage associated with the output.

For SOT402-1 (TSSOP14) package: Ptot derates linearly with 7.3 mW/K above 81 °C. For SOT762-1 (DHVQFN14) package: Ptot derates linearly with 9.6 mW/K above 98 °C.

### 9. Recommended operating conditions

Table 6. Recommended operating conditions [1] [2]

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CC(A)}$	supply voltage A		1.65	3.6	V
V <sub>CC(B)</sub>	supply voltage B		2.3	5.5	V
T <sub>amb</sub>	ambient temperature		-40	+125	°C
Δt/ΔV	input transition rise and fall rate	A or B port; push-pull driving			
		V <sub>CC(A)</sub> = 1.65 V to 3.6 V; V <sub>CC(B)</sub> = 2.3 V to 5.5 V	-	10	ns/V
		OE input			
		V <sub>CC(A)</sub> = 1.65 V to 3.6 V; V <sub>CC(B)</sub> = 2.3 V to 5.5 V	-	10	ns/V

<sup>[1]</sup> The A and B sides of an unused I/O pair must be held in the same state, both at V<sub>CCI</sub> or both at GND.

### 10. Static characteristics

**Table 7. Typical static characteristics** 

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); T<sub>amb</sub> = 25 °C.[1]

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I <sub>I</sub>	input leakage current	OE input; $V_{CC(A)} = 1.65 \text{ V to } 3.6 \text{ V}; V_{CC(B)} = 2.3 \text{ V to } 5.5 \text{ V}$	-	-	±1	μΑ
l <sub>OZ</sub>	OFF-state output current	A or B port; OE = 0 V; $V_{CC(A)} = 1.65 \text{ V to } 3.6 \text{ V}; V_{CC(B)} = 2.3 \text{ V to } 5.5 \text{ V}$	-	-	±1	μΑ
l <sub>OFF</sub>	power-off leakage current	A port; $V_{CC(A)} = 0 \text{ V}$ ; $V_{CC(B)} = 0 \text{ V}$ to 5.5 V	-	-	±1	μΑ
		B port; V <sub>CC(B)</sub> = 0 V; V <sub>CC(A)</sub> = 0 V to 3.6 V	-	-	±1	μA
Cı	input capacitance	OE input; V <sub>CC(A)</sub> = 3.3 V; V <sub>CC(B)</sub> = 3.3 V	-	2	-	pF
C <sub>I/O</sub>	input/output	A port; $V_{CC(A)} = 3.3 \text{ V}$ ; $V_{CC(B)} = 3.3 \text{ V}$				
	capacitance	enabled	-	10	-	pF
		disabled	-	4	-	pF
		B port; V <sub>CC(A)</sub> = 3.3 V; V <sub>CC(B)</sub> = 3.3 V				
		enabled	-	10	-	pF
		disabled	-	7	-	pF

<sup>[1]</sup>  $V_{CC(A)}$  must be less than or equal to  $V_{CC(B)}$  and  $V_{CC(A)}$  must not exceed 3.6 V.

### Table 8. Typical supply current

At recommended operating conditions; voltages are referenced to GND (ground = 0 V);  $T_{amb}$  = 25 °C.

V <sub>CC(A)</sub>	V <sub>CC(B)</sub>							
	2.5 V		3.3 V		5.0 V			
	I <sub>CC(A)</sub>	I <sub>CC(B)</sub>	I <sub>CC(A)</sub>	I <sub>CC(B)</sub>	I <sub>CC(A)</sub>	I <sub>CC(B)</sub>		
1.8 V	0.1	0.5	0.1	1.5	0.1	4.6	μΑ	
2.5 V	0.1	0.1	0.1	0.8	0.1	3.8	μΑ	
3.3 V	-	-	0.1	0.1	0.1	2.8	μΑ	

<sup>[2]</sup>  $V_{CC(A)}$  must be less than or equal to  $V_{CC(B)}$  and  $V_{CC(A)}$  must not exceed 3.6 V.

**Table 9. Static characteristics** 

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).[1]

Symbol	Parameter	Conditions	-40 °C to	o +85 °C	-40 °C to	+125 °C	Unit
			Min	Max	Min	Max	
V <sub>IH</sub>	HIGH-level input	A port					
	voltage	V <sub>CC(A)</sub> = 1.65 V to 1.95 V; V <sub>CC(B)</sub> = 2.3 V to 5.5 V	V <sub>CC(A)</sub> - 0.2	V <sub>CC(A)</sub>	V <sub>CC(A)</sub> - 0.2	V <sub>CC(A)</sub>	V
		V <sub>CC(A)</sub> = 2.3 V to 3.6 V; V <sub>CC(B)</sub> = 2.3 V to 5.5 V	V <sub>CC(A)</sub> - 0.4	V <sub>CC(A)</sub>	V <sub>CC(A)</sub> - 0.4	V <sub>CC(A)</sub>	V
		B port					
		V <sub>CC(A)</sub> = 1.65 V to 3.6 V; V <sub>CC(B)</sub> = 2.3 V to 5.5 V	V <sub>CC(B)</sub> - 0.4	V <sub>CC(B)</sub>	V <sub>CC(B)</sub> - 0.4	V <sub>CC(B)</sub>	V
		OE input					
		V <sub>CC(A)</sub> = 1.65 V to 3.6 V; V <sub>CC(B)</sub> = 2.3 V to 5.5 V	0.65V <sub>CC(A)</sub>	V <sub>CC(A)</sub>	0.65V <sub>CC(A)</sub>	V <sub>CC(A)</sub>	V
V <sub>IL</sub>	LOW-level input voltage	A or B port					
		V <sub>CC(A)</sub> = 1.65 V to 3.6 V; V <sub>CC(B)</sub> = 2.3 V to 5.5 V	0	0.15	0	0.15	V
		OE input					
		V <sub>CC(A)</sub> = 1.65 V to 3.6 V; V <sub>CC(B)</sub> = 2.3 V to 5.5 V	0	0.35V <sub>CC(A)</sub>	0	0.35V <sub>CC(A)</sub>	V
V <sub>OH</sub>	HIGH-level output voltage	A port; $I_O = -20 \mu A$ ; $V_I \ge V_{CC(B)} - 0.4 V$					
		V <sub>CC(A)</sub> = 1.65 V to 3.6 V; V <sub>CC(B)</sub> = 2.3 V to 5.5 V	0.67V <sub>CC(A)</sub>	-	0.67V <sub>CC(A)</sub>	-	V
		B port; $I_O = -20 \mu A$ ; $V_I \ge V_{CC(A)} - 0.2 V$					
		$V_{CC(A)} = 1.65 \text{ V to } 3.6 \text{ V};$ $V_{CC(B)} = 2.3 \text{ V to } 5.5 \text{ V}$	0.67V <sub>CC(B)</sub>	-	0.67V <sub>CC(B)</sub>	-	V
$V_{OL}$	LOW-level	A or B port; $I_O = 1$ mA; $V_I \le 0.15$ V					
	output voltage	V <sub>CC(A)</sub> = 1.65 V to 3.6 V; V <sub>CC(B)</sub> = 2.3 V to 5.5 V	-	0.4	-	0.4	V
l <sub>l</sub>	input leakage current	OE input; $V_{CC(A)} = 1.65 \text{ V to } 3.6 \text{ V};$ $V_{CC(B)} = 2.3 \text{ V to } 5.5 \text{ V}$	-	±2	-	±12	μΑ
l <sub>OZ</sub>	OFF-state output current	A or B port; $V_{CC(A)} = 1.65 \text{ V to } 3.6 \text{ V};$ $V_{CC(B)} = 2.3 \text{ V to } 5.5 \text{ V}$	-	±2	-	±12	μΑ
I <sub>OFF</sub>	power-off leakage current	A port; V <sub>CC(A)</sub> = 0 V; V <sub>CC(B)</sub> = 0 V to 5.5 V	-	±2	-	±12	μΑ
		B port; V <sub>CC(B)</sub> = 0 V; V <sub>CC(A)</sub> = 0 V to 3.6 V	-	±2	-	±12	μΑ

Symbol	Parameter	Conditions	-40 °C t	o +85 °C	-40 °C to	Unit	
			Min	Max	Min	Max	
I <sub>CC</sub>	supply current	OE = 0 V or V <sub>CC(A)</sub> ; An, Bn open					
		I <sub>CC(A)</sub>					
		$V_{CC(A)}$ = 1.65 V to 3.6 V; $V_{CC(B)}$ = 2.3 V to 5.5 V	-	2.4	-	15	μA
		V <sub>CC(A)</sub> = 3.6 V; V <sub>CC(B)</sub> = 0 V	-	2.2	-	15	μΑ
		$V_{CC(A)} = 0 \text{ V}; V_{CC(B)} = 5.5 \text{ V}$	-	-1	-	-8	μΑ
		I <sub>CC(B)</sub>					
		$V_{CC(A)}$ = 1.65 V to 3.6 V; $V_{CC(B)}$ = 2.3 V to 5.5 V	-	12	-	30	μA
		V <sub>CC(A)</sub> = 3.6 V; V <sub>CC(B)</sub> = 0 V	-	-1	-	-5	μΑ
		V <sub>CC(A)</sub> = 0 V; V <sub>CC(B)</sub> = 5.5 V	-	1	-	6	μΑ
		$I_{CC(A)} + I_{CC(B)}$					
		V <sub>CC(A)</sub> = 1.65 V to 3.6 V; V <sub>CC(B)</sub> = 2.3 V to 5.5 V	-	14.4	-	45	μA

<sup>[1]</sup>  $V_{CC(A)}$  must be less than or equal to  $V_{CC(B)}$  and  $V_{CC(A)}$  must not exceed 3.6 V.

### 11. Dynamic characteristics

Table 10. Dynamic characteristics for temperature range -40 °C to +85 °C

Voltages are referenced to GND (ground = 0 V); for test circuit see Fig. 8; for waveforms see Fig. 5 to Fig. 7.

Symbol	Parameter	Conditions			Vc	C(B)			Unit
			2.5 V	± 0.2 V	3.3 V	± 0.3 V	5.0 V ± 0.5 V		
			Min	Max	Min	Max	Min	Max	
V <sub>CC(A)</sub> =	1.8 V ± 0.15 V								
t <sub>PHL</sub>	HIGH to LOW propagation delay	A to B	-	4.6	-	4.7	-	5.8	ns
t <sub>PLH</sub>	LOW to HIGH propagation delay	A to B	-	7.1	-	6.8	-	7.0	ns
t <sub>PHL</sub>	HIGH to LOW propagation delay	B to A	-	4.4	-	4.5	-	4.7	ns
t <sub>PLH</sub>	LOW to HIGH propagation delay	B to A	-	5.3	-	4.5	-	0.5	ns
t <sub>en</sub>	enable time	OE to A, B [1]	-	200	-	200	-	200	ns
t <sub>dis</sub>	disable time	OE to A, B; no external load [1] [2]	-	35	-	35	-	35	ns
		OE to A	-	140	-	140	-	145	ns
		OE to B	-	125	-	175	-	125	ns
t <sub>TLH</sub>	LOW to HIGH	A port	3.2	9.5	2.3	9.3	1.8	7.6	ns
	output transition time	B port	3.3	10.8	2.7	9.1	2.7	7.6	ns
$t_{THL}$	HIGH to LOW	A port	2.0	5.9	1.9	6.0	1.7	13.3	ns
	output transition time	B port	2.9	7.6	2.8	7.5	2.8	10.0	ns
t <sub>sk(o)</sub>	output skew time	between channels [3]	-	0.7	-	0.7	-	0.7	ns
t <sub>W</sub>	pulse width	data inputs	41	-	41	-	41	-	ns
f <sub>data</sub>	data rate		-	24	-	24	-	24	Mbps

**Nexperia** 

### Dual supply translating transceiver; open drain; auto direction sensing

Symbol	Parameter	Conditions		V <sub>CC(B)</sub>					
			2.5 V	± 0.2 V	3.3 V :	± 0.3 V	5.0 V :	± 0.5 V	
			Min	Max	Min	Max	Min	Max	
V <sub>CC(A)</sub> =	2.5 V ± 0.2 V								•
t <sub>PHL</sub>	HIGH to LOW propagation delay	A to B	-	3.2	-	3.3	-	3.4	ns
t <sub>PLH</sub>	LOW to HIGH propagation delay	A to B	-	3.5	-	4.4	-	4.6	ns
t <sub>PHL</sub>	HIGH to LOW propagation delay	B to A	-	3.0	-	3.6	-	4.3	ns
t <sub>PLH</sub>	LOW to HIGH propagation delay	B to A	-	2.5	-	1.6	-	0.7	ns
t <sub>en</sub>	enable time	OE to A, B [1]	-	200	-	200	-	200	ns
t <sub>dis</sub>	disable time	OE to A, B; no external load [1] [2]	-	35	-	35	-	35	ns
		OE to A	-	105	-	105	-	105	ns
		OE to B	-	125	-	175	-	120	ns
t <sub>TLH</sub>	LOW to HIGH	A port	2.8	7.5	2.6	6.6	1.8	6.5	ns
	output transition time	B port	3.2	8.5	2.9	7.3	2.4	6.3	ns
t <sub>THL</sub>	HIGH to LOW	A port	1.9	5.7	1.9	5.5	1.8	5.3	ns
	output transition time	B port	2.2	7.8	2.4	6.7	2.6	6.6	ns
t <sub>sk(o)</sub>	output skew time	between channels [3]	-	0.7	-	0.7	-	0.7	ns
t <sub>W</sub>	pulse width	data inputs	41	-	41	-	41	-	ns
f <sub>data</sub>	data rate		-	24	-	24	-	24	Mbps
V <sub>CC(A)</sub> =	3.3 V ± 0.3 V								
t <sub>PHL</sub>	HIGH to LOW propagation delay	A to B	-	-	-	2.4	-	3.1	ns
t <sub>PLH</sub>	LOW to HIGH propagation delay	A to B	-	-	-	4.2	-	4.4	ns
t <sub>PHL</sub>	HIGH to LOW propagation delay	B to A	-	-	-	2.5	-	3.3	ns
t <sub>PLH</sub>	LOW to HIGH propagation delay	B to A	-	-	-	2.5	-	2.6	ns
t <sub>en</sub>	enable time	OE to A, B [1]	-	-	-	200	-	200	ns
t <sub>dis</sub>	disable time	OE to A, B; no external load [1] [2]	-	-	-	35	-	35	ns
		OE to A	-	-	-	150	-	150	ns
		OE to B	-	-	-	170	-	120	ns
t <sub>TLH</sub>	LOW to HIGH	A port	-	-	2.3	6.2	1.9	6.3	ns
	output transition time	B port	-	-	2.5	6.9	2.1	7.4	ns
t <sub>THL</sub>	HIGH to LOW	A port	-	-	2.0	5.4	1.9	5.0	ns
	output transition time	B port	-	-	2.3	7.4	2.4	7.6	ns
t <sub>sk(o)</sub>	output skew time	between channels [3]	-	-	-	0.7	-	0.7	ns
t <sub>W</sub>	pulse width	data inputs	-	-	41	-	41	-	ns
f <sub>data</sub>	data rate		-	-	-	24	-	24	Mbps

 $t_{en}$  is the same as  $t_{PZL}$  and  $t_{PZH}$ ;  $t_{dis}$  is the same as  $t_{PLZ}$  and  $t_{PHZ}$ .

<sup>[2]</sup> [3] These values are guaranteed by design.

Skew between any two outputs of the same package switching in the same direction.

Table 11. Dynamic characteristics for temperature range -40 °C to +125 °C

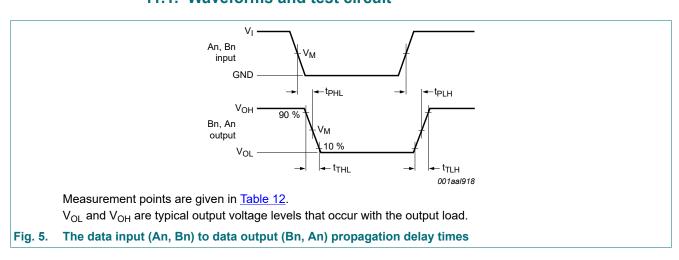
Voltages are referenced to GND (ground = 0 V); for test circuit see Fig. 8; for waveforms see Fig. 5 to Fig. 7.

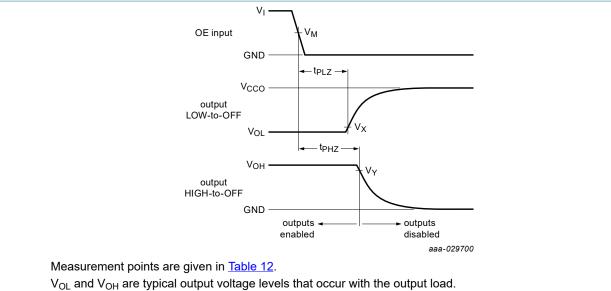
Symbol	Parameter	Conditions			Vc	C(B)			Unit
			2.5 V ± 0.2 V		3.3 V ± 0.3 V		5.0 V :	± 0.5 V	
			Min	Max	Min	Max	Min	Max	
V <sub>CC(A)</sub> =	1.8 V ± 0.15 V			<u> </u>					
t <sub>PHL</sub>	HIGH to LOW propagation delay	A to B	-	5.8	-	5.9	-	7.3	ns
t <sub>PLH</sub>	LOW to HIGH propagation delay	A to B	-	8.5	-	8.5	-	8.8	ns
t <sub>PHL</sub>	HIGH to LOW propagation delay	B to A	-	5.5	-	5.7	-	5.9	ns
t <sub>PLH</sub>	LOW to HIGH propagation delay	B to A	-	6.7	-	5.7	-	0.7	ns
t <sub>en</sub>	enable time	OE to A, B [1]	-	200	-	200	-	200	ns
t <sub>dis</sub>	disable time	OE to A, B; no external load [1] [2]	-	45	-	45	-	45	ns
		OE to A	-	140	-	140	-	145	ns
		OE to B	-	125	-	175	-	125	ns
t <sub>TLH</sub>	LOW to HIGH	A port	3.2	11.9	2.3	11.7	1.8	9.5	ns
	output transition time	B port	3.3	13.5	2.7	11.4	2.7	9.5	ns
t <sub>THL</sub>	HIGH to LOW	A port	2.0	7.4	1.9	7.5	1.7	16.7	ns
	output transition time	B port	2.9	9.5	2.8	9.4	2.8	12.5	ns
t <sub>sk(o)</sub>	output skew time	between channels [3]	-	0.8	-	0.8	-	8.0	ns
t <sub>W</sub>	pulse width	data inputs	50	-	41	-	41	-	ns
f <sub>data</sub>	data rate		-	20	-	24	-	24	Mbps
V <sub>CC(A)</sub> =	2.5 V ± 0.2 V								
t <sub>PHL</sub>	HIGH to LOW propagation delay	A to B	-	4.0	-	4.2	-	4.3	ns
t <sub>PLH</sub>	LOW to HIGH propagation delay	A to B	-	4.4	-	5.2	-	5.5	ns
t <sub>PHL</sub>	HIGH to LOW propagation delay	B to A	-	3.8	-	4.5	-	5.4	ns
t <sub>PLH</sub>	LOW to HIGH propagation delay	B to A	-	3.2	-	2.0	-	0.9	ns
t <sub>en</sub>	enable time	OE to A, B [1]	-	200	-	200	-	200	ns
t <sub>dis</sub>	disable time	OE to A, B; no external load [1] [2]	-	45	-	45	-	45	ns
		OE to A	-	105	-	105	-	105	ns
		OE to B	-	125	-	175	-	120	ns
t <sub>TLH</sub>	LOW to HIGH	A port	2.8	9.3	2.6	8.3	1.8	7.8	ns
	output transition time	B port	3.2	10.4	2.9	9.7	2.4	8.3	ns
t <sub>THL</sub>	HIGH to LOW	A port	1.9	7.2	1.9	6.9	1.8	6.7	ns
	output transition time	B port	2.2	9.8	2.4	8.4	2.6	8.3	ns
t <sub>sk(o)</sub>	output skew time	between channels [3]	-	0.8	-	0.8	-	0.8	ns
t <sub>W</sub>	pulse width	data inputs	50	-	41	-	41	-	ns
f <sub>data</sub>	data rate		-	20	-	24	-	24	Mbps

Symbol	Parameter	Conditions			$V_{CC(B)}$								
				2.5 V	± 0.2 V	3.3 V	± 0.3 V	5.0 V ± 0.5 V					
				Min	Max	Min	Max	Min	Max				
V <sub>CC(A)</sub> =	3.3 V ± 0.3 V									1			
t <sub>PHL</sub>	HIGH to LOW propagation delay	A to B		-	-	-	3.0	-	3.9	ns			
t <sub>PLH</sub>	LOW to HIGH propagation delay	A to B		-	-	-	5.3	-	5.5	ns			
t <sub>PHL</sub>	HIGH to LOW propagation delay	B to A		-	-	-	3.2	-	4.2	ns			
t <sub>PLH</sub>	LOW to HIGH propagation delay	B to A		-	-	-	3.2	-	3.3	ns			
t <sub>en</sub>	enable time	OE to A, B	[1]	-	-	-	200	-	200	ns			
t <sub>dis</sub>	disable time	OE to A, B; no external load	[1] [2]	-	-	-	45	-	45	ns			
		OE to A		-	-	-	150	-	150	ns			
		OE to B		-	-	-	170	-	120	ns			
t <sub>TLH</sub>	LOW to HIGH	A port		-	-	2.3	7.0	1.9	7.4	ns			
	output transition time	B port		-	-	2.5	8.0	2.1	9.3	ns			
t <sub>THL</sub>	HIGH to LOW	A port		-	-	2.0	6.8	1.9	6.3	ns			
	output transition time	B port		-	-	2.3	9.3	2.4	9.5	ns			
t <sub>sk(o)</sub>	output skew time	between channels	[3]	-	-	-	0.8	-	0.8	ns			
t <sub>W</sub>	pulse width	data inputs		-	-	41	-	41	-	ns			
f <sub>data</sub>	data rate			-	-	-	24	-	24	Mbps			

- [1]  $t_{en}$  is the same as  $t_{PZL}$  and  $t_{PZH}$ ;  $t_{dis}$  is the same as  $t_{PLZ}$  and  $t_{PHZ}$ .
- [2] These values are guaranteed by design.
- [3] Skew between any two outputs of the same package switching in the same direction.

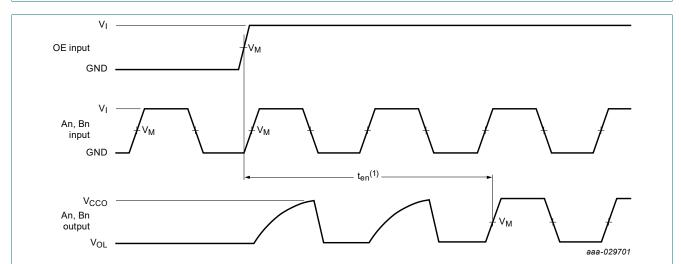
### 11.1. Waveforms and test circuit





V<sub>CCO</sub> is the supply voltage associated with the output.

**Disable times** Fig. 6.



(1) The enable time  $(t_{en})$  indicates the amount of time the user must allow for one one-shot circuitry to become operational after OE is taken HIGH. See also Section 12.6

Measurement points are given in Table 12.

V<sub>OL</sub> is a typical output voltage level that occur with the output load.

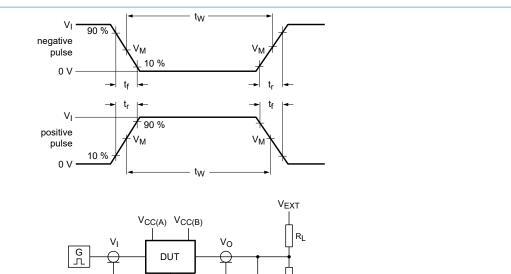
V<sub>CCO</sub> is the supply voltage associated with the output.

Fig. 7. **Enable times** 

**Table 12. Measurement points** 

Supply voltage	Input	Output					
V <sub>cco</sub>	V <sub>M</sub> [1]	V <sub>M</sub> [2]	V <sub>X</sub>	V <sub>Y</sub>			
1.8 V ± 0.15 V	0.5V <sub>CCI</sub>	0.5V <sub>CCO</sub>	V <sub>OL</sub> + 0.15 V	V <sub>OH</sub> - 0.15 V			
2.5 V ± 0.2 V	0.5V <sub>CCI</sub>	0.5V <sub>CCO</sub>	V <sub>OL</sub> + 0.15 V	V <sub>OH</sub> - 0.15 V			
3.3 V ± 0.3 V	0.5V <sub>CCI</sub>	0.5V <sub>CCO</sub>	V <sub>OL</sub> + 0.3 V	V <sub>OH</sub> - 0.3 V			
5.0 V ± 0.5 V	0.5V <sub>CCI</sub>	0.5V <sub>CCO</sub>	V <sub>OL</sub> + 0.3 V	V <sub>OH</sub> - 0.3 V			

- V<sub>CCI</sub> is the supply voltage associated with the input.
- V<sub>CCO</sub> is the supply voltage associated with the output.



aaa-029721

Test data is given in Table 13.

All input pulses are supplied by generators having the following characteristics:

PRR  $\leq$  10 MHz;  $Z_O = 50 \Omega$ ;  $dV/dt \geq 1.0 V/ns$ .

R<sub>L</sub> = Load resistance.

C<sub>L</sub> = Load capacitance including jig and probe capacitance.

V<sub>EXT</sub> = External voltage for measuring switching times.

Fig. 8. Test circuit for measuring switching times

Table 13. Test data

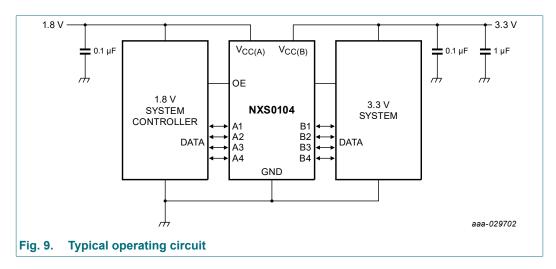
Supply voltage		Input		Load		V <sub>EXT</sub>			
V <sub>CC(A)</sub>	V <sub>CC(B)</sub>	V <sub>I</sub> [1]	Δt/ΔV	CL	R <sub>L</sub> [2]	t <sub>PLH</sub> , t <sub>PHL</sub>	t <sub>PZH</sub> , t <sub>PHZ</sub>	t <sub>PZL</sub> , t <sub>PLZ</sub> [3]	
1.65 V to 3.6 V	2.3 V to 5.5 V	$V_{CCI}$	≤ 1.0 ns/V	15 pF	50 kΩ, 1 MΩ	open	open	2V <sub>CCO</sub>	

- 1] V<sub>CCI</sub> is the supply voltage associated with the input.
- [2] For measuring data rate, pulse width, propagation delay and output rise and fall measurements,  $R_L = 1 \text{ M}\Omega$ . For measuring enable and disable times,  $R_L = 50 \text{ k}\Omega$ .
- [3]  $V_{\text{CCO}}$  is the supply voltage associated with the output.

### 12. Application information

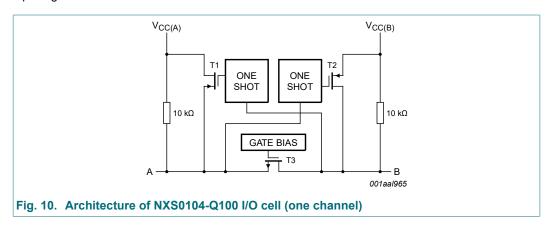
### 12.1. Applications

Voltage level-translation applications. The NXS0104-Q100 can be used in point-to-point applications to interface between devices or systems operating at different supply voltages. The device is primarily targeted at I<sup>2</sup>C or 1-wire which use open-drain drivers, it may also be used in applications where push-pull drivers are connected to the ports, however the NXB0104-Q100 may be more suitable.



#### 12.2. Architecture

The architecture of the NXS0104-Q100 is shown in <u>Fig. 10</u>. The device does not require an extra input signal to control the direction of data flow from A to B or B to A.



The NXS0104-Q100 is a "switch" type voltage translator, it employs two key circuits to enable voltage translation:

- 1. A pass-gate transistor (N-channel) that ties the ports together.
- 2. An output edge-rate accelerator that detects and accelerates rising edges on the I/O pins.

The gate bias voltage of the pass gate transistor (T3) is set at approximately one threshold voltage above the V<sub>CC</sub> level of the low-voltage side. During a LOW-to-HIGH transition the output one-shot accelerates the output transition by switching on the PMOS transistors (T1, T2) bypassing the 10 k $\Omega$  pull-up resistors and increasing current drive capability. The one-shot is activated once the input transition reaches approximately 0.5V<sub>CCI</sub>; it is de-activated approximately 50 ns after the output reaches 0.5V<sub>CCO</sub>. During the acceleration time the driver output resistance is between approximately 50  $\Omega$  and 70  $\Omega$ .

To avoid signal contention and minimize dynamic  $I_{CC}$ , the user should wait for the one-shot circuit to turn-off before applying a signal in the opposite direction. Pull-up resistors are included in the device for DC current sourcing capability.

### 12.3. Input driver requirements

As the NXS0104-Q100 is a switch type translator, properties of the input driver directly effect the output signal. The external open-drain or push-pull driver applied to an I/O determines the static current sinking capability of the system; the max data rate, HIGH-to-LOW output transition time  $(t_{THL})$  and propagation delay  $(t_{PHL})$  are dependent upon the output impedance and edge-rate of the external driver. The limits provided for these parameters in the datasheet assume a driver with output impedance below 50  $\Omega$  is used.

### 12.4. Output load considerations

The maximum lumped capacitive load that can be driven is dependant upon the one-shot pulse duration. In cases with very heavy capacitive loading there is a risk that the output will not reach the positive rail within the one-shot pulse duration. To avoid excessive capacitive loading and to ensure correct triggering of the one-shot it's recommended to use short trace lengths and low capacitance connectors on NXS0104-Q100 PCB layouts. To ensure low impedance termination and avoid output signal oscillations and one-shot re-triggering, the length of the PCB trace should be such that the round trip delay of any reflection is within the one-shot pulse duration.

### 12.5. Power up

During operation  $V_{CC(A)}$  must never be higher than  $V_{CC(B)}$ , however during power-up  $V_{CC(B)} \ge V_{CC(B)}$  does not damage the device, so any power supply can be ramped up first. There is no special power-up sequencing required. The NXS0104-Q100 includes circuitry that disables all output ports when either  $V_{CC(A)}$  or  $V_{CC(B)}$  is switched off.

#### 12.6. Enable and disable

An output enable input (OE) is used to disable the device. Setting OE to LOW causes all I/Os to assume the high-impedance OFF-state. The disable time ( $t_{\rm dis}$  with no external load) indicates the delay between when OE goes LOW and when outputs actually become disabled. The enable time ( $t_{\rm en}$ ) indicates the amount of time the user must allow for one one-shot circuitry to become operational after OE is taken HIGH. To ensure the high-impedance OFF-state during power-up or power-down, pin OE should be tied to GND through a pull-down resistor, the minimum value of the resistor is determined by the current-sourcing capability of the driver.

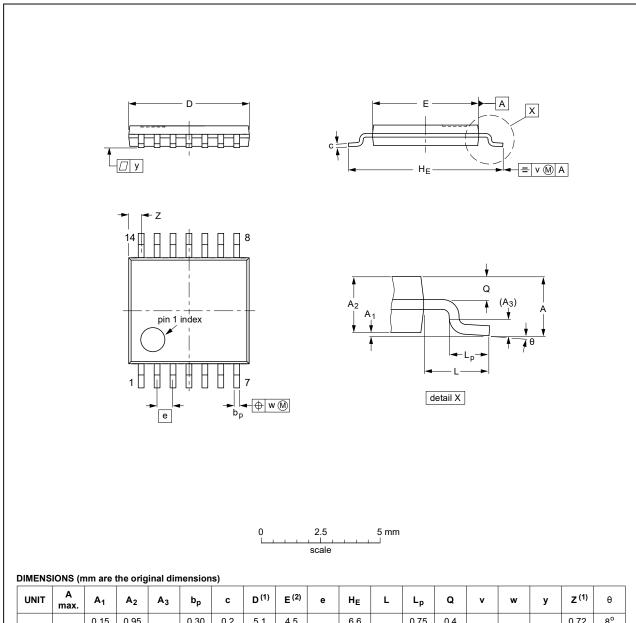
### 12.7. Pull-up or pull-down resistors on I/O lines

Each A port I/O has an internal 10 k $\Omega$  pull-up resistor to  $V_{CC(A)}$ , and each B port I/O has an internal 10 k $\Omega$  pull-up resistor to  $V_{CC(B)}$ . If a smaller value of pull-up resistor is required, an external resistor must be added parallel to the internal 10 k $\Omega$ , this will effect the  $V_{OL}$  level. When OE goes LOW the internal pull-ups of the NXS0104-Q100 are disabled.

### 13. Package outline

TSSOP14: plastic thin shrink small outline package; 14 leads; body width 4.4 mm

SOT402-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	b <sub>p</sub>	С	D <sup>(1)</sup>	E <sup>(2)</sup>	е	HE	L	Lp	Q	v	w	у	Z <sup>(1)</sup>	θ
mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	5.1 4.9	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.72 0.38	8° 0°

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT402-1		MO-153			<del>99-12-27</del> 03-02-18

Fig. 11. Package outline SOT402-1 (TSSOP14)

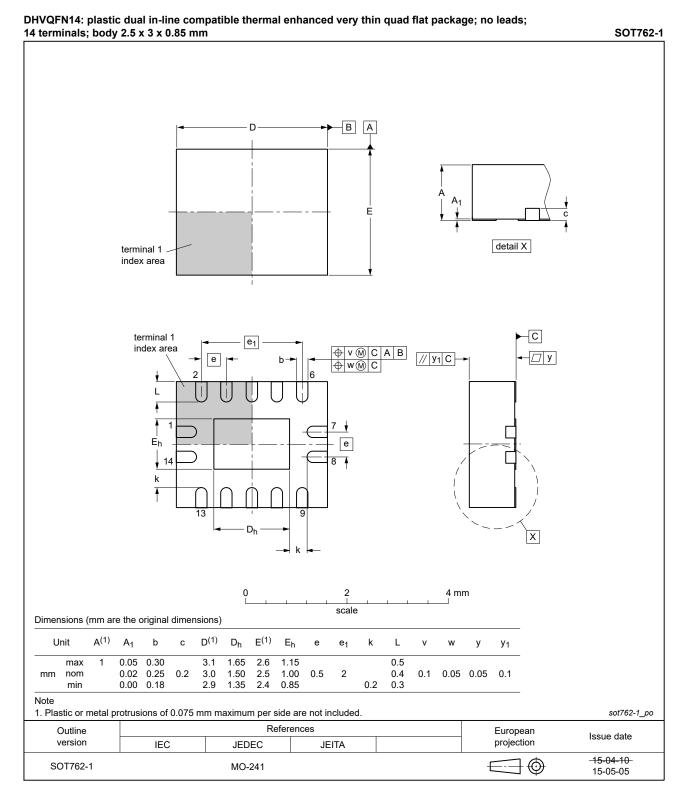


Fig. 12. Package outline SOT762-1 (DHVQFN14)

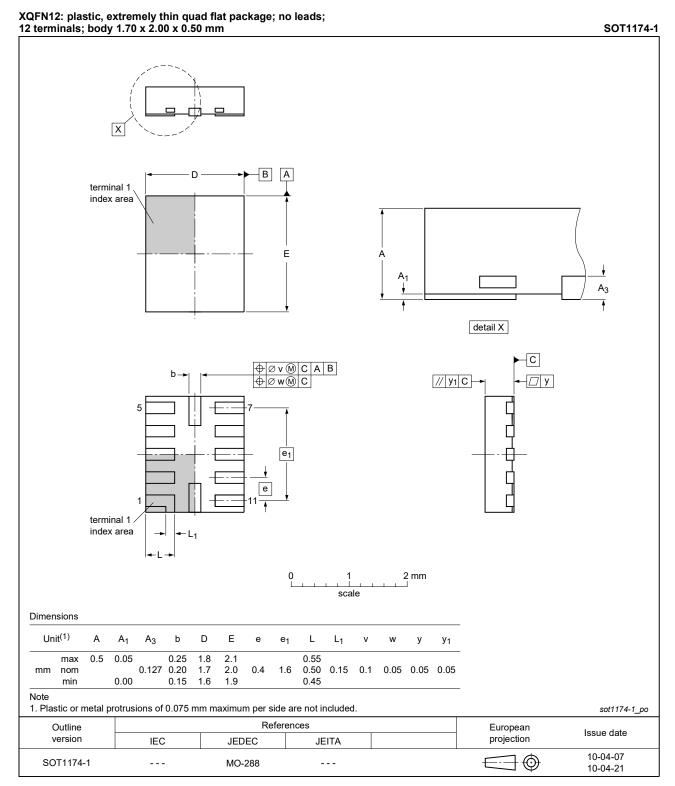


Fig. 13. Package outline SOT1174-1 (XQFN12)

### 14. Abbreviations

### **Table 14. Abbreviations**

Acronym	Description
DUT	Device Under Test
ESD	ElectroStatic Discharge
НВМ	Human Body Model
I <sup>2</sup> C	Inter-Integrated Circuit
MIL	Military
PCB	Printed Circuit Board
PRR	Pulse Rate Repetition

### 15. Revision history

#### **Table 15. Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes				
NXS0104_Q100 v.5	20220502	Product data sheet	-	NXS0104_Q100 v.4				
Modifications:	Type number	Type number NXS0104GU12-Q100 (SOT1174-1/XQFN12) added.						
NXS0104_Q100 v.4	20201113	Product data sheet	-	NXS0104_Q100 v.3				
Modifications:	• <u>Table 10</u> an	d <u>Table 11</u> : Disable times ι	ıpdated.					
NXS0104_Q100 v.3	20200827	Product data sheet	-	NXS0104_Q100 v.2				
Modifications:		pdated. Derating values for P <sub>tot</sub> tota id <u>Table 11</u> : Footnotes corre	•	n updated.				
NXS0104_Q100 v.2	20190619	Product data sheet	-	NXS0104_Q100 v.1				
Modifications:		<ul> <li>Added type number NXS0104BQ-Q100 (SOT762-1/DHVQFN14).</li> <li>Section 8: total power dissipation changed to 500 mW.</li> </ul>						
NXS0104_Q100 v.1	20190401	Product data sheet	-	-				

### 16. Legal information

#### **Data sheet status**

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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